

<b>Notice of References Cited</b>	Application/Control No. 10/620,880	Applicant(s)/Patent Under Reexamination SENDA ET AL.	
	Examiner Katherine W. Mitchell	Art Unit 3677	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2003/0130363	07-2003	Meguriya, Noriyuki	521/54
	B	US-5,179,148	01-1993	Inoue et al.	524/265
	C	US-5,240,765	08-1993	Takahashi et al.	521/94
	D	US-5,610,230	03-1997	Yoshida et al.	524/730
	E	US-6,720,103	04-2004	Nagai, Osamu	429/36
	F	US-4,337,332	06-1982	Melancon et al.	528/15
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 406271684	09-1994	JP	Shin Etsu	C08J 005/12
	O	EP 1220345	07-2002	JP	NAGAI	H01M 8/02
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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